



General Description

The SJB02N5000 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a wide variety of applications.

Features

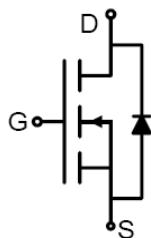
- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

Application

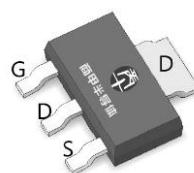
- PWM Applications
- Load Switch
- Power Management

Key Performance Parametes

Parameter	Value	Unit
V_{DS}	200	V
$R_{DS(ON)}_{TYP}$	471	mΩ
I_D	1.3	A
Q_G	16.8	nC



Schematic Diagram



SOT-223-3L top view

Package Marking and Ordering Information

Device/Ordering Code	Marking	Package	Reel Size	Tape width	Quantity
SJB02N5000	SJB02N5000	SOT-223-3L			

Table 1. Absolute Maximum Ratings ($T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V_{DS}	Drain-Source Voltage ($V_{GS}=0\text{V}$)	200	V
V_{GS}	Gate-Source Voltage ($V_{DS}=0\text{V}$)	± 20	V
I_D	Drain Current-Continuous($T_A=25^\circ\text{C}$)	1.3	A
	Drain Current-Continuous($T_A=100^\circ\text{C}$)	0.86	A
I_{DM} (pulse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	5.2	A
P_D	Maximum Power Dissipation($T_A=25^\circ\text{C}$)	2.5	W
	Maximum Power Dissipation($T_A=100^\circ\text{C}$)	1	W
E_{AS}	Avalanche energy (Note 2)	10.6	mJ
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 To 150	°C

Table 2. Thermal Characteristic

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		50	°C/W



200V N-Channel Trench Power MOSFET

Table 3. Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
On/Off States						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_{\text{D}}=250\mu\text{A}$	200			V
$I_{\text{DS}}^{\text{SS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=200\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$			1	μA
		$V_{\text{DS}}=200\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$			± 100	nA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$			± 100	nA
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{D}}=250\mu\text{A}$	1		3	V
g_{FS}	Forward Transconductance	$V_{\text{DS}}=5\text{V}$, $I_{\text{D}}=2\text{A}$		6		S
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=10\text{V}$, $I_{\text{D}}=2\text{A}$, $T_J=25^\circ\text{C}$		471	611	$\text{m}\Omega$
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=4.5\text{V}$, $I_{\text{D}}=2\text{A}$, $T_J=25^\circ\text{C}$		478.6	636.5	$\text{m}\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=100\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1.0\text{MHz}$		742		pF
C_{oss}	Output Capacitance			14		pF
C_{rss}	Reverse Transfer Capacitance			5		pF
Switching Parameters						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{GS}}=10\text{V}$, $V_{\text{DS}}=100\text{V}$, $R_{\text{L}}=50\Omega$, $R_{\text{GEN}}=2.5\Omega$		10		nS
t_r	Turn-on Rise Time			13		nS
$t_{\text{d(off)}}$	Turn-Off Delay Time			16		nS
t_f	Turn-Off Fall Time			14		nS
Q_g	Total Gate Charge	$V_{\text{GS}}=10\text{V}$, $V_{\text{DS}}=100\text{V}$, $I_{\text{D}}=2\text{A}$		16.8		nC
Q_{gs}	Gate-Source Charge			2.4		nC
Q_{gd}	Gate-Drain Charge			6.8		nC
Source-Drain Diode Characteristics						
I_{SD}	Source-Drain Current (Body Diode)				1.3	A
V_{SD}	Forward on Voltage (Note 2)	$V_{\text{GS}}=0\text{V}$, $I_{\text{S}}=2\text{A}$			1.2	V
t_{rr}	Reverse Recovery Time	$I_{\text{F}}=2\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		86		ns
Q_{rr}	Reverse Recovery Charge	$I_{\text{F}}=2\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		290		nC

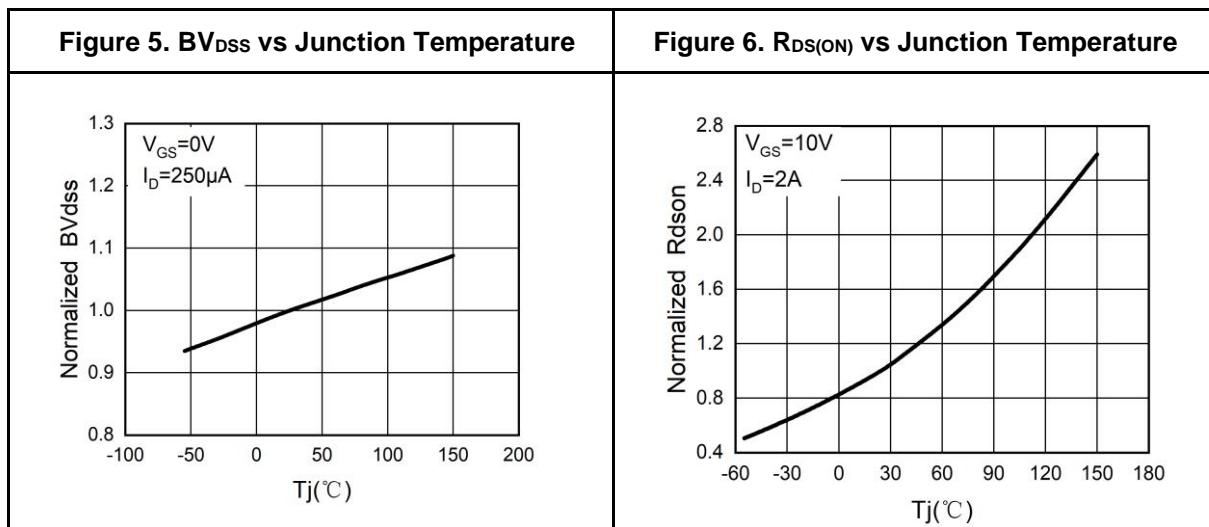
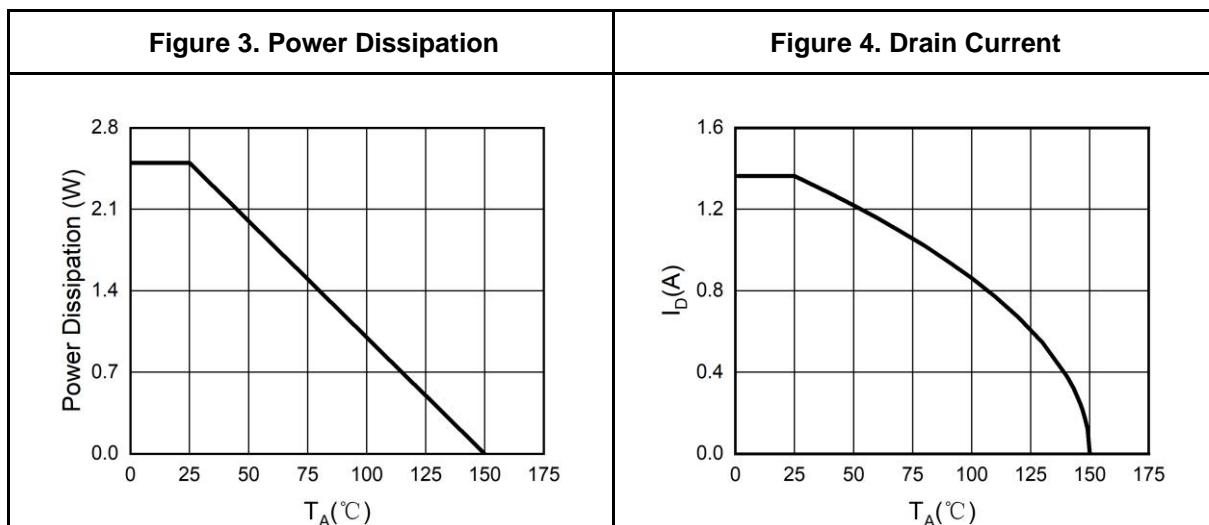
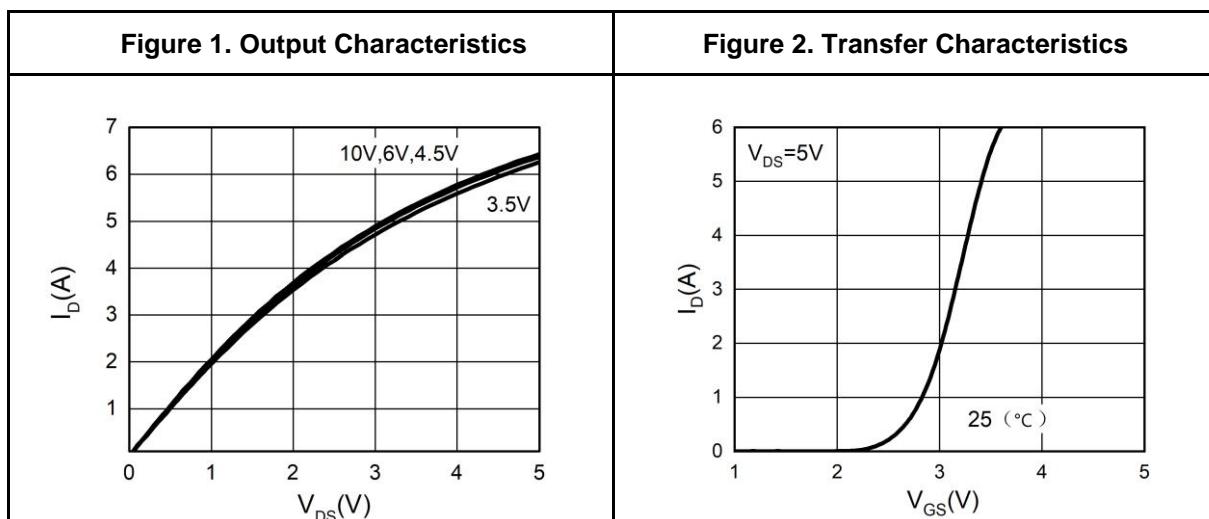
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

Notes 2.E_{AS} condition: $T_J=25^\circ\text{C}$, $V_{\text{DD}}=40\text{V}$, $V_{\text{G}}=10\text{V}$, $R_{\text{G}}=25\Omega$, $L=0.5\text{mH}$.

Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

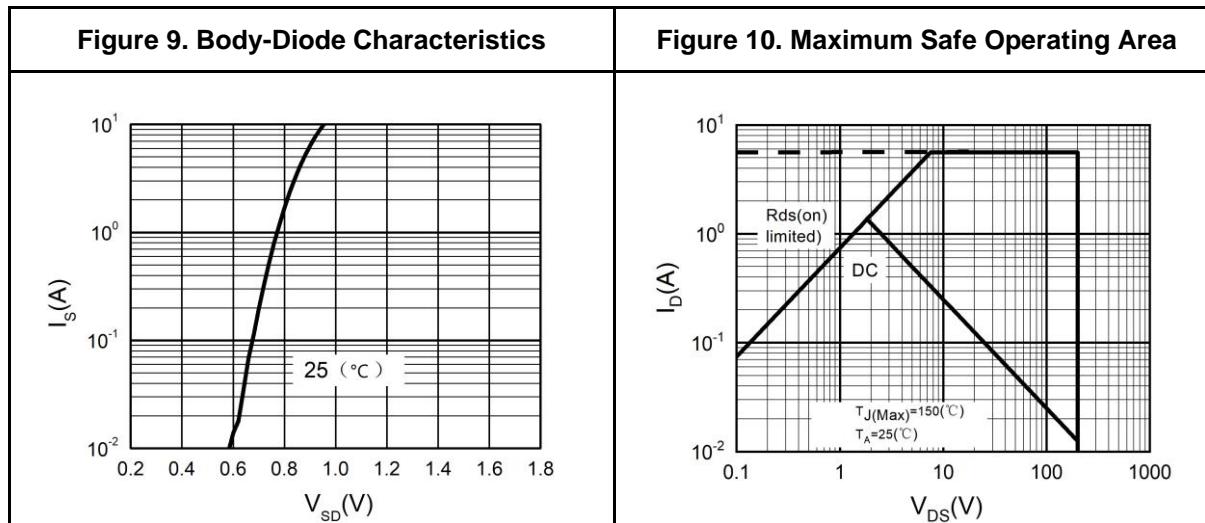
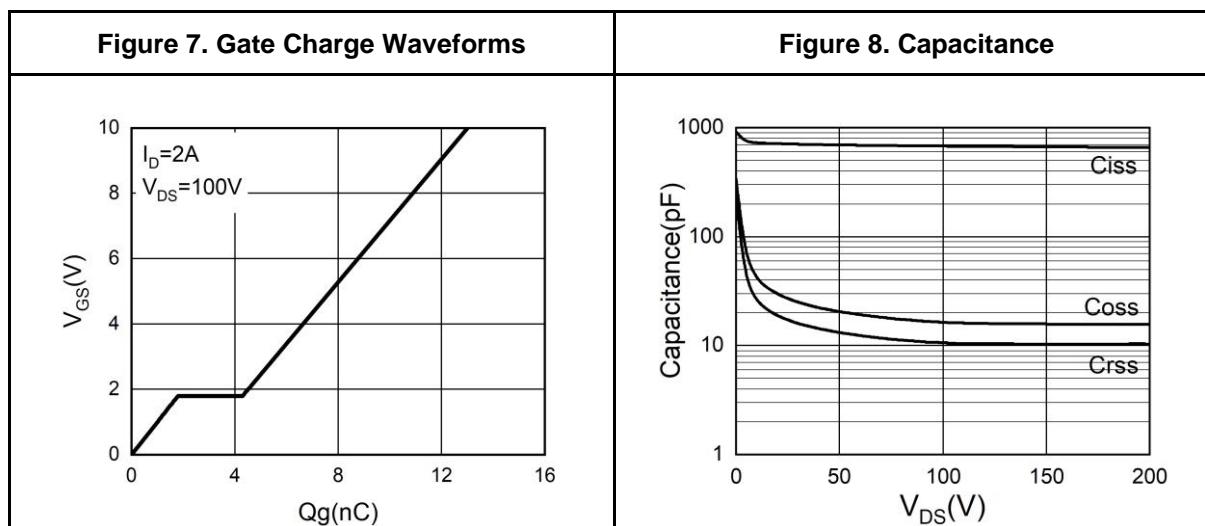


Typical Electrical And Thermal Characteristics (Curves)



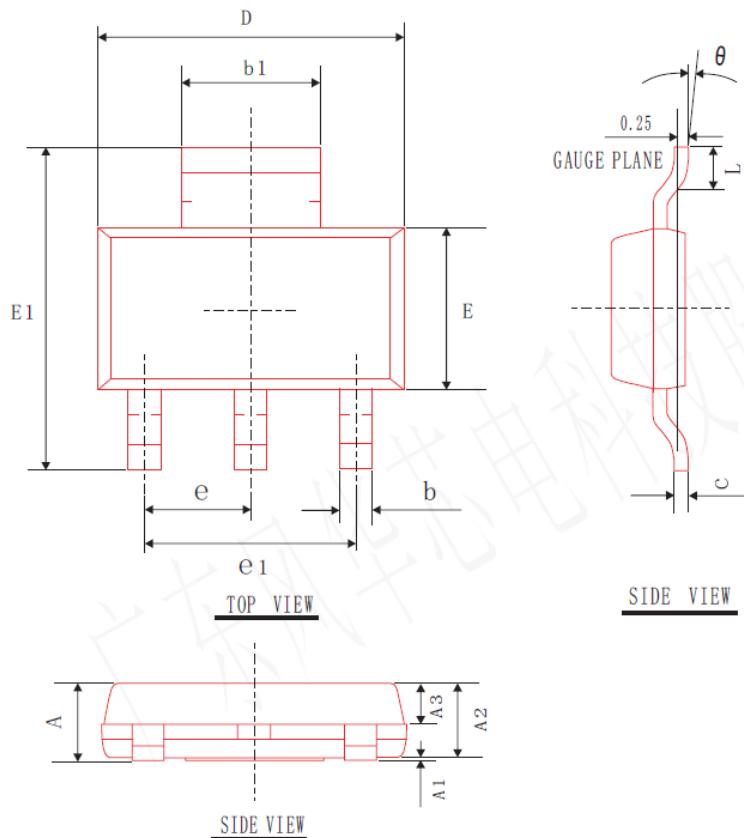


Typical Electrical And Thermal Characteristics (Curves)





SOT-223-3L Package Information



COMMON DIMENSIONS
(UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX
A	—	—	1.80
A ₁	0.00	0.05	0.10
A ₂	1.50	1.60	1.70
A ₃	0.85	0.90	0.95
b	0.66	0.70	0.80
b ₁	2.96	3.00	3.10
c	0.25	0.30	0.35
D	6.30	6.50	6.70
E	3.30	3.50	3.70
E ₁	6.80	7.00	7.20
e	4.40	4.60	4.80
L	0.90	—	1.15
θ	0°	5°	10°
e		2.3 BSC	



Attention

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor.

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